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1-(4-Chlorophenyl)-4,4-dimethylpent-1en-3-one

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Key indicators: single-crystal X-ray study; T = 173 K; mean σ (C–C) = 0.002 Å; R factor = 0.032; wR factor = 0.094; data-to-parameter ratio = 16.2.

In the title compound, $C_{13}H_{15}ClO$, the carbonyl and ethenyl groups are not coplanar with benzene ring system, forming dihedral angles of 35.37 (5) and 36.27 (11)°, respectively. The molecules are packed in an offset face-to-face arrangement showing π - π stacking interactions involving the benzene rings [centroid–centroid distance = 3.586 (4) Å].

Related literature

The title compound is an important intermediate in the pesticide industry, see: Wang *et al.* (2006). For related structures, see: Anuradha *et al.* (2008); Butcher *et al.* (2007); Gong *et al.* (2008); Harrison *et al.* (2007); Patil *et al.* (2007); Sarojini *et al.* (2007); Thiruvalluvar *et al.* (2007); Thiruvalluvar *et al.* (2008); Xia & Hu (2008).



Experimental

Crystal data	
C ₁₃ H ₁₅ ClO	a = 5.6831 (4) Å
$M_r = 222.70$	b = 9.9156 (6) Å
Triclinic, P1	c = 11.3731 (7) Å

$\alpha = 103.487 \ (1)^{\circ}$	
$\beta = 101.160 \ (1)^{\circ}$	
$\gamma = 103.697 \ (1)^{\circ}$	
V = 584.12 (7) Å ³	
Z = 2	

Data collection

Bruker SMART 1000 CCD
diffractometer
Absorption correction: multi-scan
(SADABS; Sheldrick, 2004)
$T_{\rm min} = 0.875, \ T_{\rm max} = 0.940$

Refinement

$R[F^2 > 2\sigma(F^2)] = 0.032$	139 parameters
$wR(F^2) = 0.094$	H-atom parameters constrained
S = 1.07	$\Delta \rho_{\rm max} = 0.26 \text{ e} \text{ Å}^{-3}$
2251 reflections	$\Delta \rho_{\rm min} = -0.24 \text{ e} \text{ Å}^{-3}$

Data collection: *SMART* (Bruker, 2001); cell refinement: *SAINT-Plus* (Bruker, 2003); data reduction: *SAINT-Plus*; program(s) used to solve structure: *SHELXS97* (Sheldrick, 2008); program(s) used to refine structure: *SHELXL97* (Sheldrick, 2008); molecular graphics: *SHELXTL* (Sheldrick, 2008); software used to prepare material for publication: *SHELXTL*.

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Supplementary data and figures for this paper are available from the IUCr electronic archives (Reference: PV2132).

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Mo $K\alpha$ radiation $\mu = 0.30 \text{ mm}^{-1}$

 $0.46 \times 0.31 \times 0.21$ mm

4545 measured reflections 2251 independent reflections

1989 reflections with $I > 2\sigma(I)$

T = 173 (2) K

 $R_{\rm int} = 0.016$

supplementary materials

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1-(4-Chlorophenyl)-4,4-dimethylpent-1-en-3-one

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Comment

The title compound, 1-(4-chlorophenyl)-4,4-dimethylpentan-3-one, is a very important intermediate in the pesticides industry (Wang *et al.*, 2006). Continuing our work (Xia & Hu 2008) we have now synthsized the title compound, (I). In this article we report the synthesis and crystal structure of (I). Several crystal structures containing phenylprop-2-en-1-one moiety have been recently published, e.g., Anuradha *et al.* (2008); Butcher *et al.* (2007); Gong *et al.* (2008); Harrison *et al.* (2007); Patil *et al.* (2007); Sarojini *et al.* (2007); Thiruvalluvar *et al.* (2007); Thiruvalluvar *et al.* (2008); Xia & Hu (2008).

In the title compound (Fig. 1), the carbonyl and ethenyl groups are not coplanar with the benzene ring; the mean planes of the carbonyl group (atoms O1/C2/C3/C4) and ethenyl group (atoms C2, C3, C4 and C8) are inclined at 35.37 (5) and 36.27 (11) °, respectively, with the mean-plane of the phenyl ring (C8-C13). The bond lengths and bond angles in (I) are in excellent agreement with the corresponding bond lengths and angles reported in the related compounds given above. The molecules are packed in an offset face-to-face arrangement showing π - π stacking interaction involving the benzene rings with centroid-to-centroid distance = 3.586 (4) Å. The structure is devoid of any classical hydrogen bonds (Fig. 2).

Experimental

Added 3,3-dimethylbutan-2-one (0.0105 mol) to a solution of 4-dichlorobenzaldehyde (0.01 mol) and 60 ml ethanol dropwise. Then added 0.1 g 50% NaOH solution as catalyst and stirred at 333 K for 4 h (monitored by TLC). A part of solvent was evaporated, then cooled the mixture to 277 K and the precipitate formed were filtered and dried, giving the desired product (yield: 92.1%). Crystals suitable for X-ray structure determination were obtained by slow evaporation of an ethanol solution at room temperature.

Refinement

The methyl H atom were positioned geometrically (C—H=0.98 Å) and torsion angles refine to fit the electron density [Uĩso~(H) = 1.5U~eq~(C)]. Other H atoms were placed in calculated position (methylene C—H=0.95Å and aromatic C—H=0.95Å) and refine as riding [Uĩso~(H) = 1.2U~eq~(C)].

Figures



Fig. 1. Molecular structure of the title compound showing 30% probability displacement ellipsoids.



Fig. 2. Packing diagram of the title compound.

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Crystal data	
C ₁₃ H ₁₅ ClO	Z = 2
$M_r = 222.70$	$F_{000} = 236$
Triclinic, <i>P</i> T	$D_{\rm x} = 1.266 {\rm Mg m}^{-3}$
Hall symbol: -P 1	Melting point: 360 K
a = 5.6831 (4) Å	Mo $K\alpha$ radiation $\lambda = 0.71073$ Å
<i>b</i> = 9.9156 (6) Å	Cell parameters from 3394 reflections
c = 11.3731 (7) Å	$\theta = 2.2 - 27.0^{\circ}$
$\alpha = 103.487 \ (1)^{\circ}$	$\mu = 0.30 \text{ mm}^{-1}$
$\beta = 101.160 \ (1)^{\circ}$	T = 173 K
$\gamma = 103.697 \ (1)^{\circ}$	Block, colorless
V = 584.12 (7) Å ³	$0.46 \times 0.31 \times 0.21 \text{ mm}$

Data collection

Bruker SMART 1000 CCD diffractometer	2251 independent reflections
Radiation source: fine-focus sealed tube	1989 reflections with $I > 2\sigma(I)$
Monochromator: graphite	$R_{\rm int} = 0.016$
T = 173 K	$\theta_{max} = 26.0^{\circ}$
ω scans	$\theta_{\min} = 1.9^{\circ}$
Absorption correction: multi-scan (SADABS; Sheldrick, 2004)	$h = -6 \rightarrow 7$
$T_{\min} = 0.875, T_{\max} = 0.940$	$k = -12 \rightarrow 11$
4545 measured reflections	$l = -13 \rightarrow 13$

Refinement

Refinement on F^2	Secondary atom site location: difference Fourier map
Least-squares matrix: full	Hydrogen site location: inferred from neighbouring sites
$R[F^2 > 2\sigma(F^2)] = 0.032$	H-atom parameters constrained
$wR(F^2) = 0.094$	$w = 1/[\sigma^2(F_o^2) + (0.0518P)^2 + 0.1538P]$ where $P = (F_o^2 + 2F_c^2)/3$

<i>S</i> = 1.07	$(\Delta/\sigma)_{max} = 0.001$
2251 reflections	$\Delta\rho_{max} = 0.26 \text{ e } \text{\AA}^{-3}$
139 parameters	$\Delta \rho_{min} = -0.24 \text{ e } \text{\AA}^{-3}$

Primary atom site location: structure-invariant direct Extinction correction: none

Special details

Experimental. ¹H NMR(400MHz, CDCl3),delta:1.23(s, 9H, 3×CH₃),7.09(d, J= 1.52Hz, 1H, 2-CH), 7.36(d, J=8.4Hz, 2H, benzene 3,5-H), 7.5(d, J= 8.4Hz, 2H, benzene 2,6-H), 7.60(d,J=15.6Hz, 1H, 1-CH).

Geometry. All e.s.d.'s (except the e.s.d. in the dihedral angle between two l.s. planes) are estimated using the full covariance matrix. The cell e.s.d.'s are taken into account individually in the estimation of e.s.d.'s in distances, angles and torsion angles; correlations between e.s.d.'s in cell parameters are only used when they are defined by crystal symmetry. An approximate (isotropic) treatment of cell e.s.d.'s is used for estimating e.s.d.'s involving l.s. planes.

Refinement. Refinement of F^2 against ALL reflections. The weighted *R*-factor *wR* and goodness of fit *S* are based on F^2 , conventional *R*-factors *R* are based on *F*, with *F* set to zero for negative F^2 . The threshold expression of $F^2 > \sigma(F^2)$ is used only for calculating *R*-factors(gt) *etc.* and is not relevant to the choice of reflections for refinement. *R*-factors based on F^2 are statistically about twice as large as those based on *F*, and *R*- factors based on ALL data will be even larger.

Fractional atomic coordinates and isotropic or equivalent isotropic displacement parameters (A^2)

	x	У	Ζ	$U_{\rm iso}*/U_{\rm eq}$
Cl1	1.79614 (7)	1.22580 (4)	1.45960 (3)	0.03998 (15)
C1	0.8701 (3)	0.81783 (15)	1.07764 (13)	0.0281 (3)
H1	0.7164	0.8160	1.0994	0.034*
C2	0.8553 (3)	0.73017 (15)	0.96684 (13)	0.0292 (3)
H2	1.0047	0.7274	0.9420	0.035*
C3	0.6090 (3)	0.63638 (15)	0.88112 (13)	0.0274 (3)
C4	0.6118 (3)	0.51705 (15)	0.76919 (13)	0.0275 (3)
C5	0.3442 (3)	0.43184 (18)	0.69238 (15)	0.0415 (4)
H5A	0.2516	0.3883	0.7452	0.062*
H5B	0.3480	0.3550	0.6213	0.062*
H5C	0.2609	0.4974	0.6612	0.062*
C6	0.7443 (3)	0.41555 (16)	0.81908 (14)	0.0347 (3)
H6A	0.6574	0.3762	0.8757	0.052*
H6B	0.9188	0.4701	0.8647	0.052*
H6C	0.7412	0.3357	0.7487	0.052*
C7	0.7574 (3)	0.58705 (17)	0.68748 (14)	0.0361 (3)
H7A	0.7492	0.5121	0.6122	0.054*
H7B	0.9330	0.6345	0.7350	0.054*
H7C	0.6827	0.6593	0.6631	0.054*
C8	1.0991 (3)	0.91697 (14)	1.16967 (13)	0.0273 (3)
C9	1.3206 (3)	0.96763 (15)	1.13599 (13)	0.0310 (3)
Н9	1.3244	0.9365	1.0510	0.037*
C10	1.5339 (3)	1.06235 (16)	1.22452 (14)	0.0316 (3)
H10	1.6825	1.0972	1.2005	0.038*
C11	1.5282 (3)	1.10569 (14)	1.34851 (13)	0.0291 (3)

supplementary materials

C12	1.3137 (3)	1.05773	(16) 1.3	38509 (14)	0.0328 (3)	
H12	1.3126	1.0879	1.4	4706	0.039*	
C13	1.0999 (3)	0.96487	(15) 1.2	29538 (14)	0.0312 (3)	
H13	0.9506	0.9331	1.3	3199	0.037*	
01	0.41421 (19)	0.65539	(12) 0.9	90060 (10)	0.0373 (3)	
Atomic dis	placement parameters	$(Å^2)$				
	U^{11}	U^{22}	U^{33}	U^{12}	U^{13}	U^{23}
Cl1	0.0345 (2)	0.0357 (2)	0.0361 (2)	0.00107 (16	0.00176 (15)	0.00061 (16)
C1	0.0257 (7)	0.0273 (7)	0.0319 (7)	0.0092 (5)	0.0075 (6)	0.0087 (6)
C2	0.0238 (7)	0.0309 (7)	0.0321 (7)	0.0091 (6)	0.0080 (5)	0.0063 (6)
C3	0.0254 (7)	0.0293 (7)	0.0287 (7)	0.0088 (6)	0.0075 (5)	0.0093 (6)
C4	0.0246 (7)	0.0287 (7)	0.0271 (7)	0.0079 (5)	0.0056 (5)	0.0053 (6)
C5	0.0286 (8)	0.0434 (9)	0.0394 (8)	0.0077 (7)	0.0024 (6)	-0.0039 (7)
C6	0.0376 (8)	0.0324 (8)	0.0378 (8)	0.0137 (6)	0.0122 (6)	0.0121 (6)
C7	0.0434 (9)	0.0384 (8)	0.0333 (8)	0.0166 (7)	0.0163 (7)	0.0134 (6)
C8	0.0289 (7)	0.0237 (7)	0.0299 (7)	0.0106 (6)	0.0065 (5)	0.0071 (5)
C9	0.0318 (8)	0.0323 (7)	0.0277 (7)	0.0087 (6)	0.0085 (6)	0.0068 (6)
C10	0.0272 (7)	0.0324 (7)	0.0342 (8)	0.0067 (6)	0.0087 (6)	0.0097 (6)
C11	0.0283 (7)	0.0219 (6)	0.0320 (7)	0.0065 (5)	0.0024 (6)	0.0039 (5)
C12	0.0360 (8)	0.0310 (7)	0.0284 (7)	0.0095 (6)	0.0081 (6)	0.0039 (6)
C13	0.0286 (7)	0.0312 (7)	0.0333 (7)	0.0081 (6)	0.0112 (6)	0.0067 (6)
01	0.0247 (5)	0.0442 (6)	0.0382 (6)	0.0109 (5)	0.0093 (4)	0.0016 (5)

Geometric parameters (Å, °)

Cl1—C11	1.7401 (15)	С6—Н6В	0.9800
C1—C2	1.328 (2)	С6—Н6С	0.9800
C1—C8	1.464 (2)	C7—H7A	0.9800
C1—H1	0.9500	С7—Н7В	0.9800
C2—C3	1.4855 (19)	С7—Н7С	0.9800
С2—Н2	0.9500	C8—C13	1.396 (2)
C3—O1	1.2185 (17)	C8—C9	1.400 (2)
C3—C4	1.5281 (19)	C9—C10	1.383 (2)
C4—C5	1.5242 (19)	С9—Н9	0.9500
C4—C7	1.535 (2)	C10—C11	1.384 (2)
C4—C6	1.5368 (19)	C10—H10	0.9500
C5—H5A	0.9800	C11—C12	1.378 (2)
С5—Н5В	0.9800	C12—C13	1.385 (2)
С5—Н5С	0.9800	C12—H12	0.9500
С6—Н6А	0.9800	С13—Н13	0.9500
C2—C1—C8	126.64 (13)	H6B—C6—H6C	109.5
С2—С1—Н1	116.7	С4—С7—Н7А	109.5
C8—C1—H1	116.7	C4—C7—H7B	109.5
C1—C2—C3	121.13 (13)	H7A—C7—H7B	109.5
C1—C2—H2	119.4	С4—С7—Н7С	109.5
С3—С2—Н2	119.4	H7A—C7—H7C	109.5

O1—C3—C2	120.51 (13)	H7B—C7—H7C	109.5
O1—C3—C4	122.12 (13)	C13—C8—C9	118.03 (13)
C2—C3—C4	117.37 (12)	C13—C8—C1	119.85 (13)
C5—C4—C3	110.10 (12)	C9—C8—C1	122.13 (13)
C5—C4—C7	109.81 (12)	C10—C9—C8	121.03 (13)
C3—C4—C7	108.91 (11)	С10—С9—Н9	119.5
C5—C4—C6	110.00 (12)	С8—С9—Н9	119.5
C3—C4—C6	108.29 (11)	C9—C10—C11	119.20 (13)
C7—C4—C6	109.71 (12)	С9—С10—Н10	120.4
C4—C5—H5A	109.5	C11—C10—H10	120.4
C4—C5—H5B	109.5	C12—C11—C10	121.34 (13)
H5A—C5—H5B	109.5	C12—C11—Cl1	119.52 (11)
С4—С5—Н5С	109.5	C10—C11—C11	119.13 (11)
H5A—C5—H5C	109.5	C11—C12—C13	119.01 (13)
H5B—C5—H5C	109.5	C11—C12—H12	120.5
С4—С6—Н6А	109.5	C13—C12—H12	120.5
С4—С6—Н6В	109.5	C12—C13—C8	121.37 (13)
H6A—C6—H6B	109.5	C12—C13—H13	119.3
С4—С6—Н6С	109.5	C8—C13—H13	119.3
Н6А—С6—Н6С	109.5		
C8—C1—C2—C3	-178.96 (13)	C13—C8—C9—C10	0.0 (2)
C1—C2—C3—O1	12.6 (2)	C1C8C10	179.39 (13)
C1—C2—C3—C4	-167.46 (13)	C8—C9—C10—C11	0.9 (2)
O1—C3—C4—C5	-0.29 (19)	C9-C10-C11-C12	-0.8 (2)
C2—C3—C4—C5	179.76 (12)	C9-C10-C11-Cl1	-179.58 (11)
O1—C3—C4—C7	120.17 (15)	C10-C11-C12-C13	-0.3 (2)
C2—C3—C4—C7	-59.79 (16)	Cl1—C11—C12—C13	178.49 (11)
O1—C3—C4—C6	-120.59 (15)	C11—C12—C13—C8	1.3 (2)
C2—C3—C4—C6	59.46 (16)	C9—C8—C13—C12	-1.1 (2)
C2-C1-C8-C13	-158.39 (14)	C1—C8—C13—C12	179.47 (13)
C2—C1—C8—C9	22.2 (2)		







